

**Search Notes**

Application/Control No.

10/806,160

Examiner

Mark Ruthkosky

Applicant(s)/Patent under  
Reexamination

MIURA ET AL.

Art Unit

1795

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated search	11/07	MR